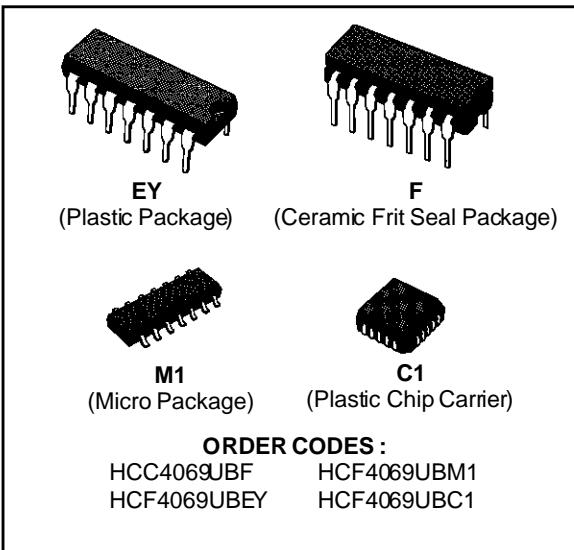


HEX INVERTER

- MEDIUM-SPEED OPERATION
– $t_{PHL}, t_{PLH} = 30\text{ns}$ (typ.) AT 10V
- QUIESCENT CURRENT SPECIFIED TO 20V FOR HCC DEVICE
- STANDARDIZED SYMMETRICAL OUTPUT CHARACTERISTICS
- 5V, 10V, AND 15V PARAMETRIC RATINGS
- INPUT CURRENT OF 100nA AT 18V AND 25°C FOR HCC DEVICE
- 100% TESTED FOR QUIESCENT CURRENT
- MEETS ALL REQUIREMENTS OF JEDEC TENTATIVE STANDARD N°13A, "STANDARD SPECIFICATIONS FOR DESCRIPTION OF "B" SERIES CMOS DEVICES"

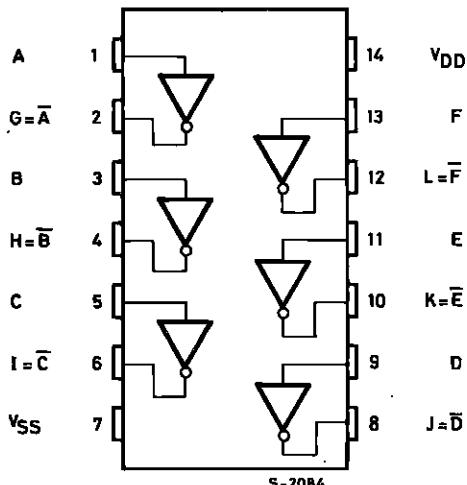


DESCRIPTION

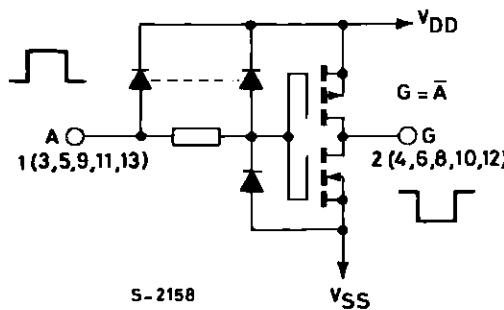
The **HCC4069UB** (extended temperature range) and **HCF4069UB** (intermediate temperature range) are monolithic integrated circuit, available in 14-lead dual in-line plastic or ceramic package and plastic micro package.

The **HCC/HCF4069UB** consists of six COS/MOS inverter circuits. This device is intended for all general-purpose inverter applications where the medium-power TTL-drive and logic-level-conversion capabilities of circuits such as **HCC/HCF4049B** Hex Inverter/Buffers are not required.

PIN CONNECTIONS



SCHEMATIC DIAGRAM OF ONE OF SIX IDENTICAL INVERTERS.



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{DD}^*	Supply Voltage : HCC Types HCF Types	– 0.5 to + 20 – 0.5 to + 18	V
V_i	Input Voltage	– 0.5 to V_{DD} + 0.5	V
I_I	DC Input Current (any one input)	± 10	mA
P_{tot}	Total Power Dissipation (per package) Dissipation per Output Transistor for Top = Full Package-temperature Range	200 100	mW
T_{op}	Operating Temperature : HCC Types HCF Types	– 55 to + 125 – 40 to + 85	°C
T_{stg}	Storage Temperature	– 65 to + 150	°C

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for external periods may affect device reliability.

* All voltage values are referred to V_{SS} pin voltage.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V_{DD}	Supply Voltage : HCC Types HCF Types	3 to 18 3 to 15	V
V_i	Input Voltage	0 to V_{DD}	V
T_{op}	Operating Temperature : HCC Types HCF Types	– 55 to + 125 – 40 to + 85	°C

STATIC ELECTRICAL CHARACTERISTICS (over recommended operating conditions)

Symbol	Parameter	Test Conditions				Value						Unit	
		V_I (V)	V_o (V)	$ I_o $ (μ A)	V_{DD} (V)	T_{Low}^*		$25^\circ C$			T_{High}^*		
						Min.	Max.	Min.	Typ.	Max.	Min.	Max.	
I_L	Quiescent Current	HCC Types	0/ 5		5		0.25		0.01	0.25		7.5	μ A
			0/10		10		0.5		0.01	0.5		15	
			0/15		15		1		0.01	1		30	
			0/20		20		5		0.02	5		150	
		HCF Types	0/ 5		5		1		0.01	1		7.5	
			0/10		10		2		0.01	2		15	
			0/15		15		4		0.01	4		30	
V_{OH}	Output High Voltage	0/ 5	< 1	5	4.95		4.95				4.95		V
		0/10	< 1	10	9.95		9.95				9.95		
		0/15	< 1	15	14.95		14.95				14.95		
V_{OL}	Output Low Voltage	5/0	< 1	5		0.05				0.05		0.05	V
		10/0	< 1	10		0.05				0.05		0.05	
		15/0	< 1	15		0.05				0.05		0.05	
V_{IH}	Input High Voltage	0.5/4.5	< 1	5	4		4				4		V
		1/9	< 1	10	8		8				8		
		1.5/13.5	< 1	15	12.5		12.5				12.5		
V_{IL}	Input Low Voltage	4.5/0.5	< 1	5		1				1		1	V
		9/1	< 1	10		2				2		2	
		13.5/1.5	< 1	15		2.5				2.5		2.5	
I_{OH}	Output Drive Current	HCC Types	0/ 5	2.5		5	- 2		- 1.6	- 3.2		- 1.15	mA
			0/ 5	4.6		5	- 0.64		- 0.51	- 1		- 0.36	
			0/10	9.5		10	- 1.6		- 1.3	- 2.6		- 0.9	
			0/15	13.5		15	- 4.2		- 3.4	- 6.8		- 2.4	
		HCF Types	0/ 5	2.5		5	- 1.53		- 1.36	- 3.2		- 1.1	
			0/ 5	4.6		5	- 0.52		- 0.44	- 1		- 0.36	
			0/10	9.5		10	- 1.3		- 1.1	- 2.6		- 0.9	
			0/15	13.5		15	- 3.6		- 3.0	- 6.8		- 2.4	
I_{OL}	Output Sink Current	HCC Types	0/ 5	0.4		5	0.64		0.51	1		0.36	mA
			0/10	0.5		10	1.6		1.3	2.6		0.9	
			0/15	1.5		15	4.2		3.4	6.8		2.4	
		HCF Types	0/ 5	0.4		5	0.52		0.44	1		0.36	
			0/10	0.5		10	1.3		1.1	2.6		0.9	
			0/15	1.5		15	3.6		3.0	6.8		2.4	
I_{IH}, I_{IL}	Input Leakage Current	HCC Types	0/18	Any Input		18	± 0.1		$\pm 10^{-5}$	± 0.1		± 1	μ A
		HCF Types	0/15			15	± 0.3		$\pm 10^{-5}$	± 0.3		± 1	
C_I	Input Capacitance		Any Input						5	7.5			pF

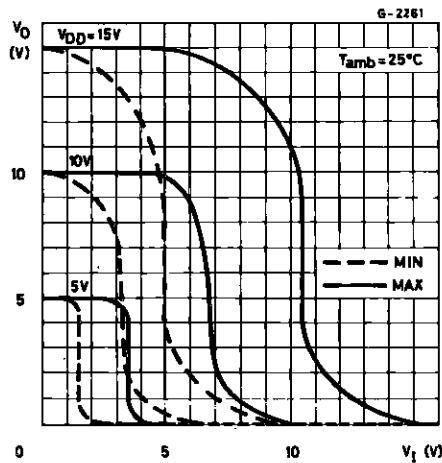
* T_{Low} = - 55°C for HCC device : - 40°C for HCF device.* T_{High} = + 125°C for HCC device : + 85°C for HCF device.The Noise Margin for both "1" and "0" level is : 1V min. with V_{DD} = 5V, 2V min. with V_{DD} = 10V, 2.5V min. with V_{DD} = 15V.

HCC/HCF4069UB

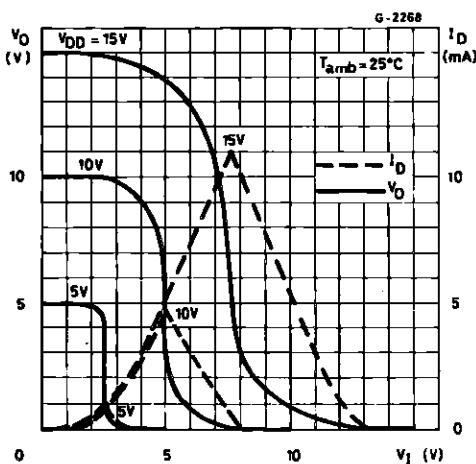
DYNAMIC ELECTRICAL CHARACTERISTICS ($T_{amb} = 25^\circ C$, $C_L = 50pF$, $R_L = 200k\Omega$, typical temperature coefficient for all $V_{DD} = 0.3\%/\text{ }^\circ C$ values, all input rise and fall time = 20ns)

Symbol	Parameter	Test Conditions			Value	Unit	
			V_{DD} (V)	Min.	Typ.	Max.	
t_{PLH}, t_{PHL}	Propagation Delay Time		5		55	110	ns
			10		30	60	
			15		25	50	
t_{TLH}, t_{THL}	Transition Time		5		100	200	ns
			10		50	100	
			15		40	80	

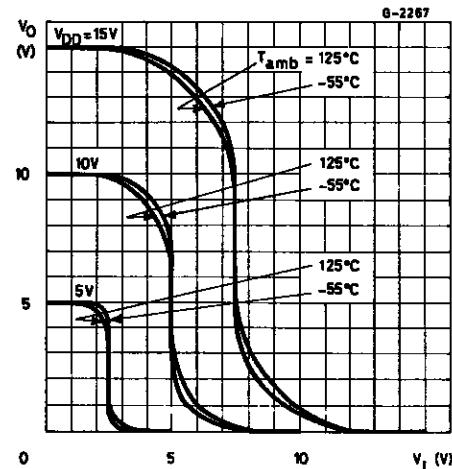
Minimum and Maximum Voltage Transfer Characteristics.



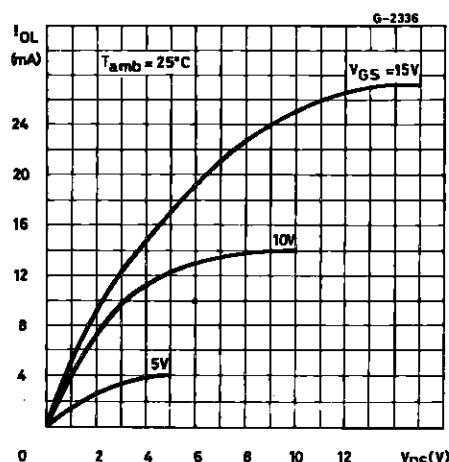
Typical Current and Voltage Transfer Characteristics.



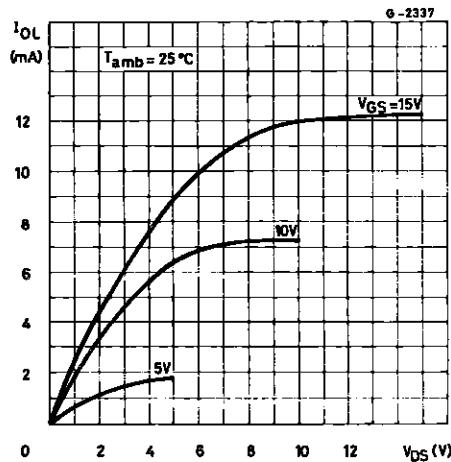
Typical Voltage Transfer Characteristics as a Function of Temperature.



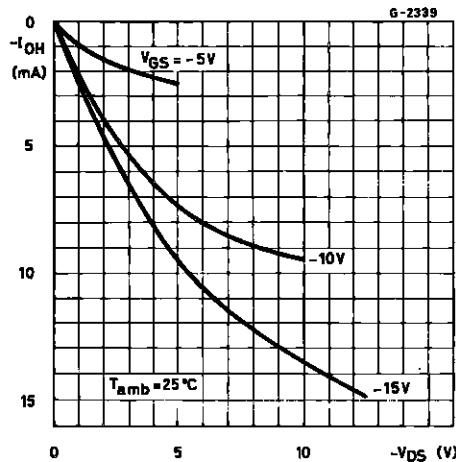
Typical Output Low (sink) Current Characteristics.



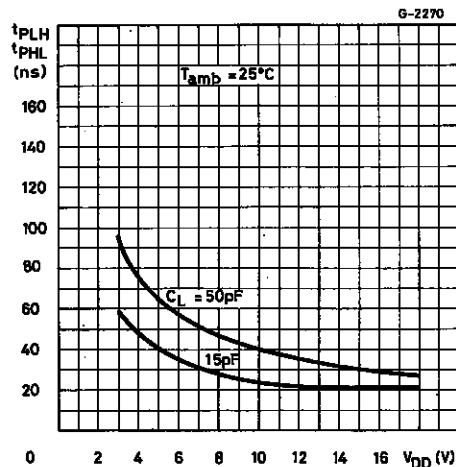
Minimum Output Low (sink) Current Characteristics.



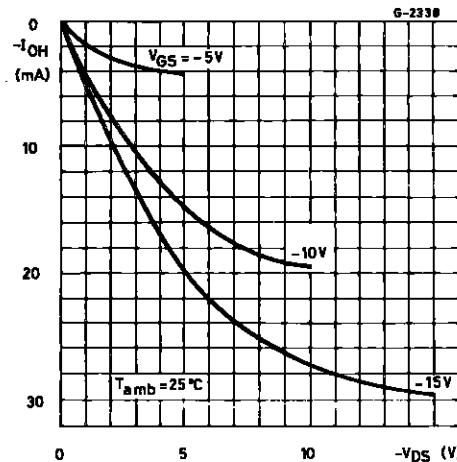
Minimum Output High (source) Current Characteristics.



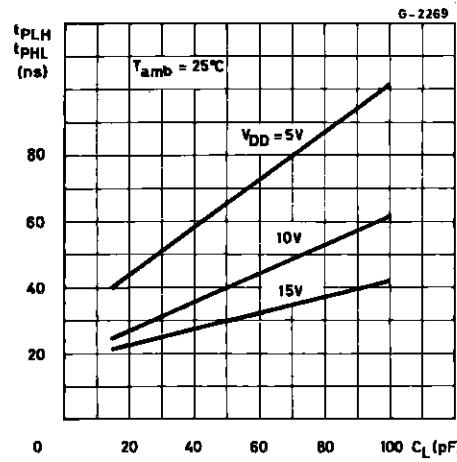
Typical Propagation Delay Time vs. Load Capacitance.



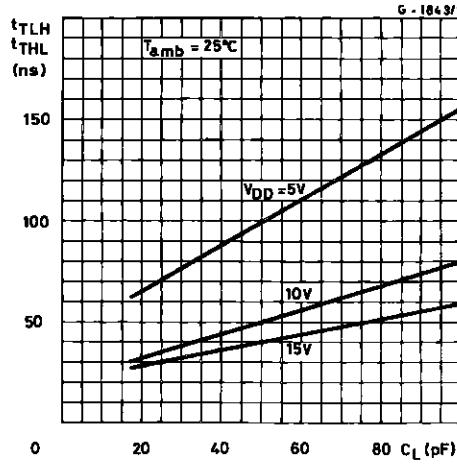
Typical Output High (source) Current Characteristics.



Typical Propagation Delay Time vs. Load Capacitance.

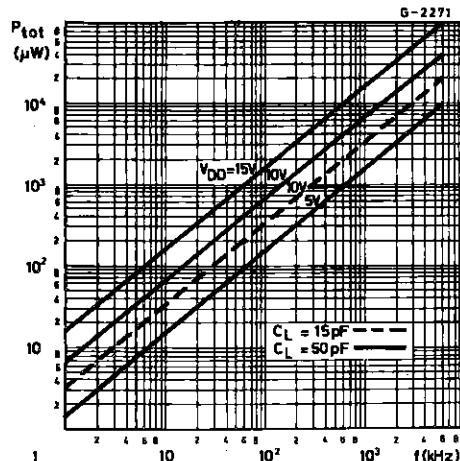


Typical Transition Time vs. Load Capacitance.

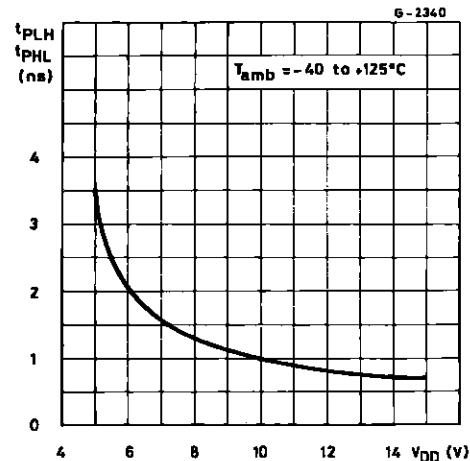


HCC/HCF4069UB

Typical Dynamic Power Dissipation/per Inverter vs. Frequency.

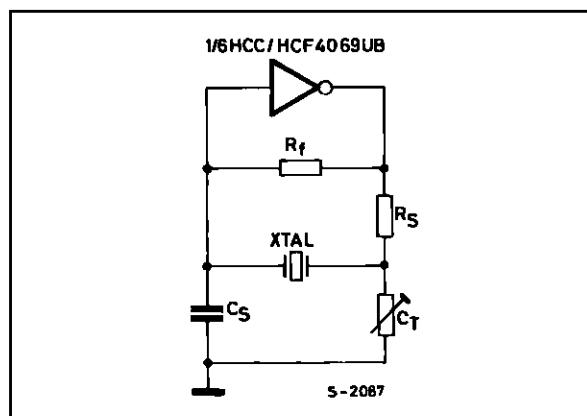


Variation of Normalized Propagation Delay Time (t_{PHL} and t_{PLH}) with Supply Voltage.

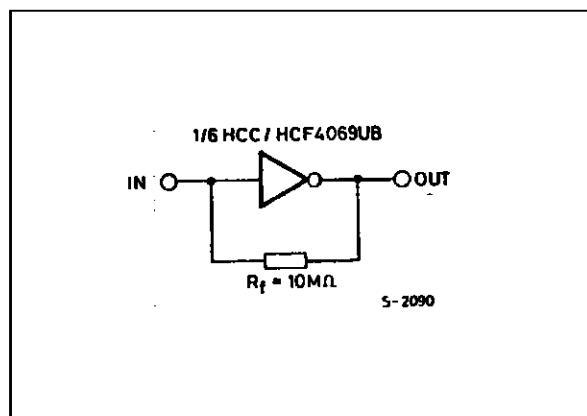


APPLICATIONS

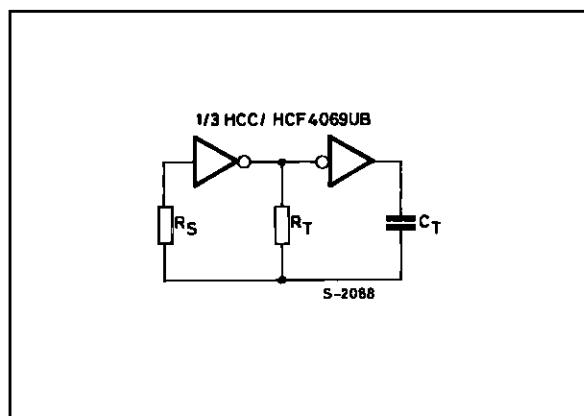
Typical Crystal Oscillator Circuit.



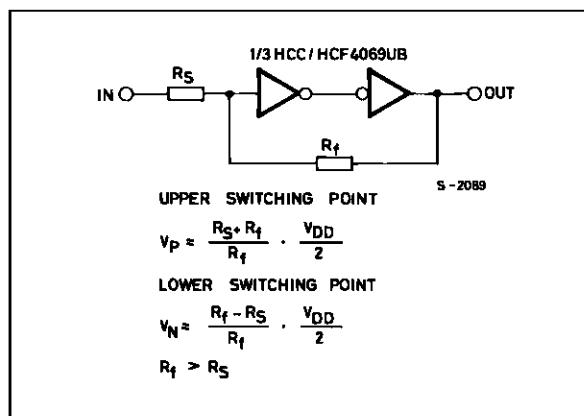
High Input Impedance Amplifier.



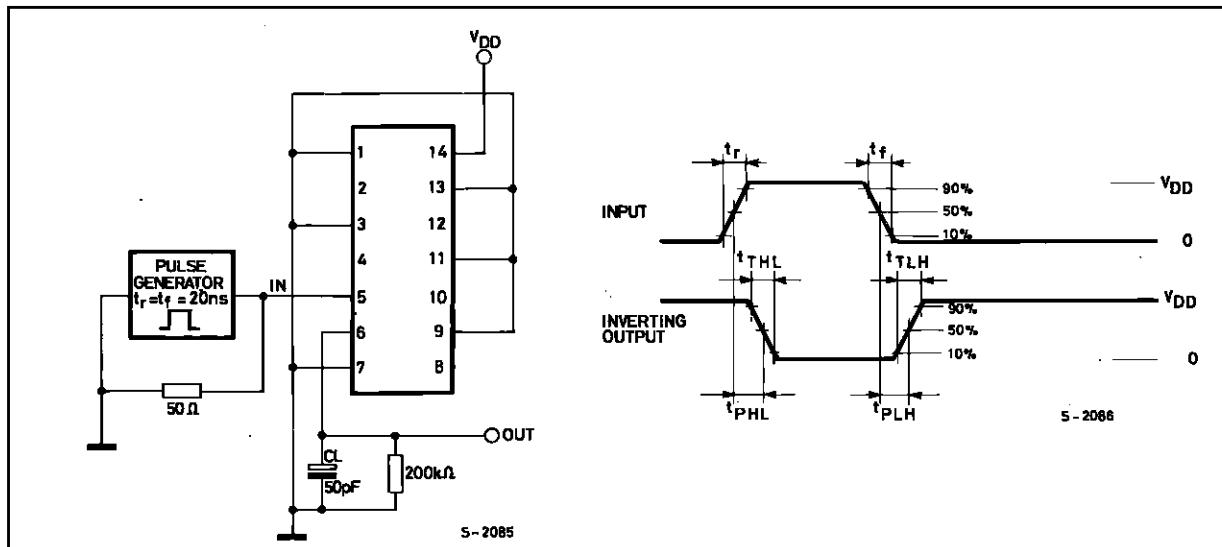
Typical RC Oscillator Circuit.



Input Pulse Shaping Circuit (schmitt trigger).

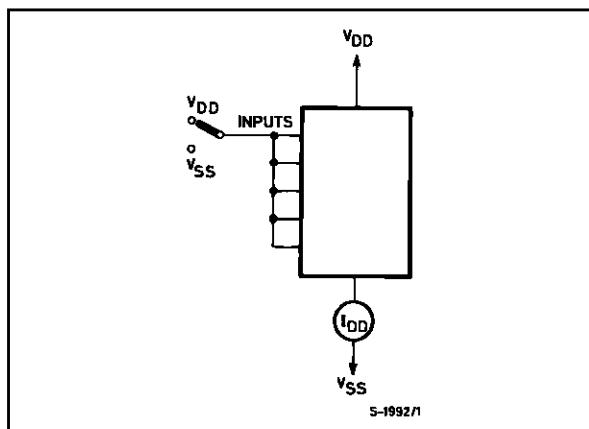


DYNAMIC ELECTRICAL CHARACTERISTICS AND WAVEFORMS

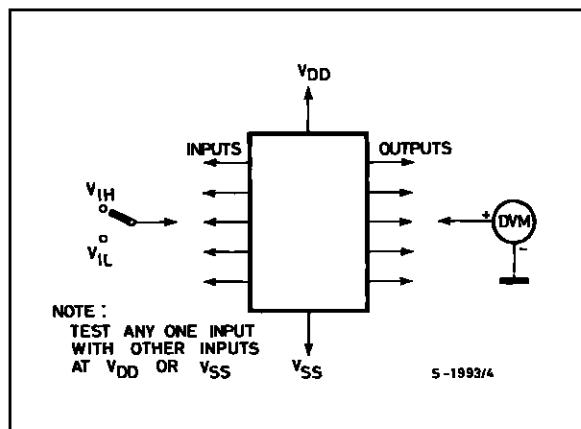


TEST CIRCUITS

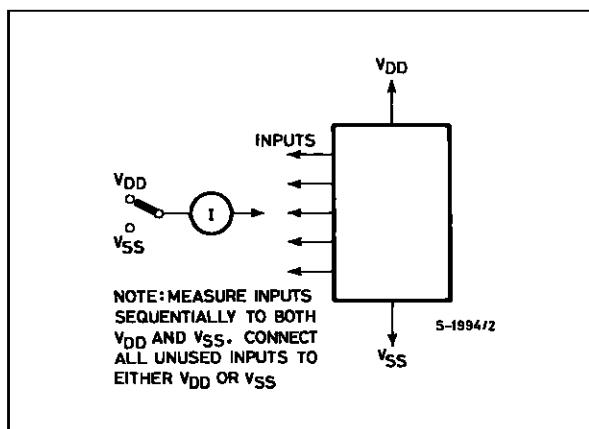
Quiescent Device Current.



Noise Immunity.

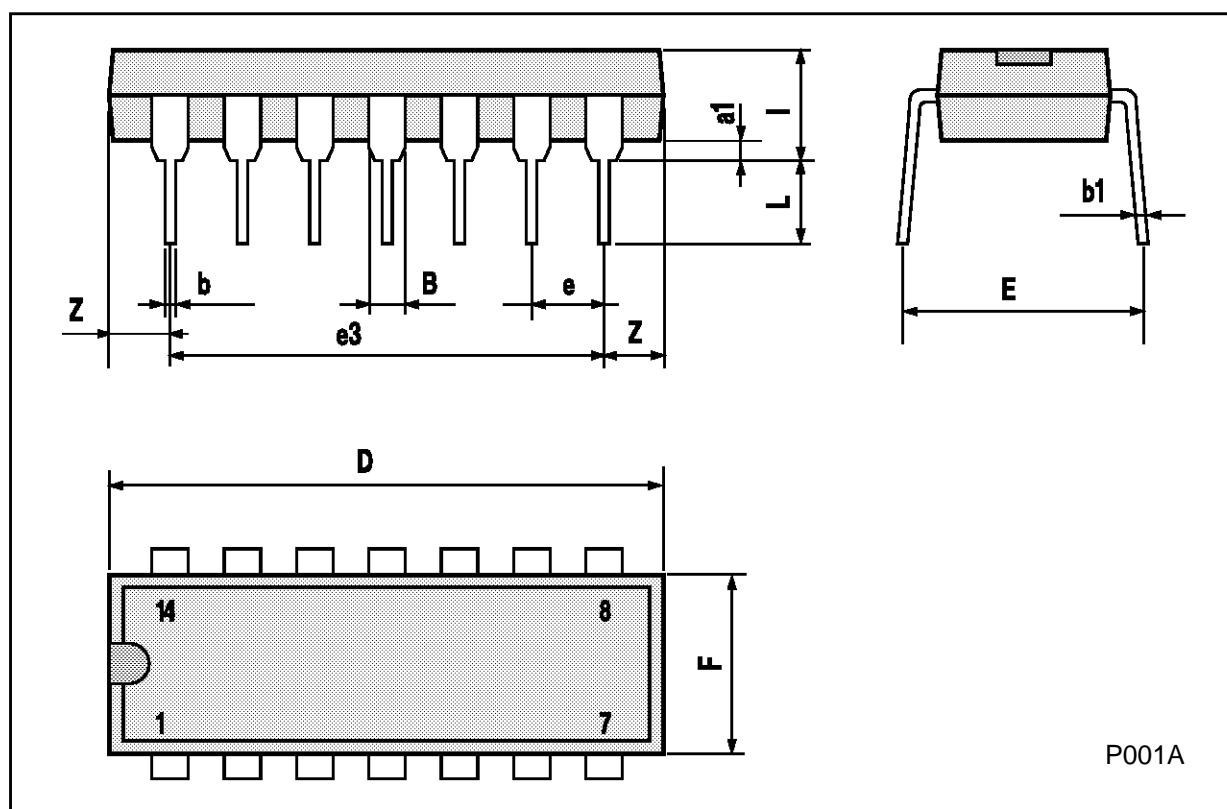


Input Leakage Current.



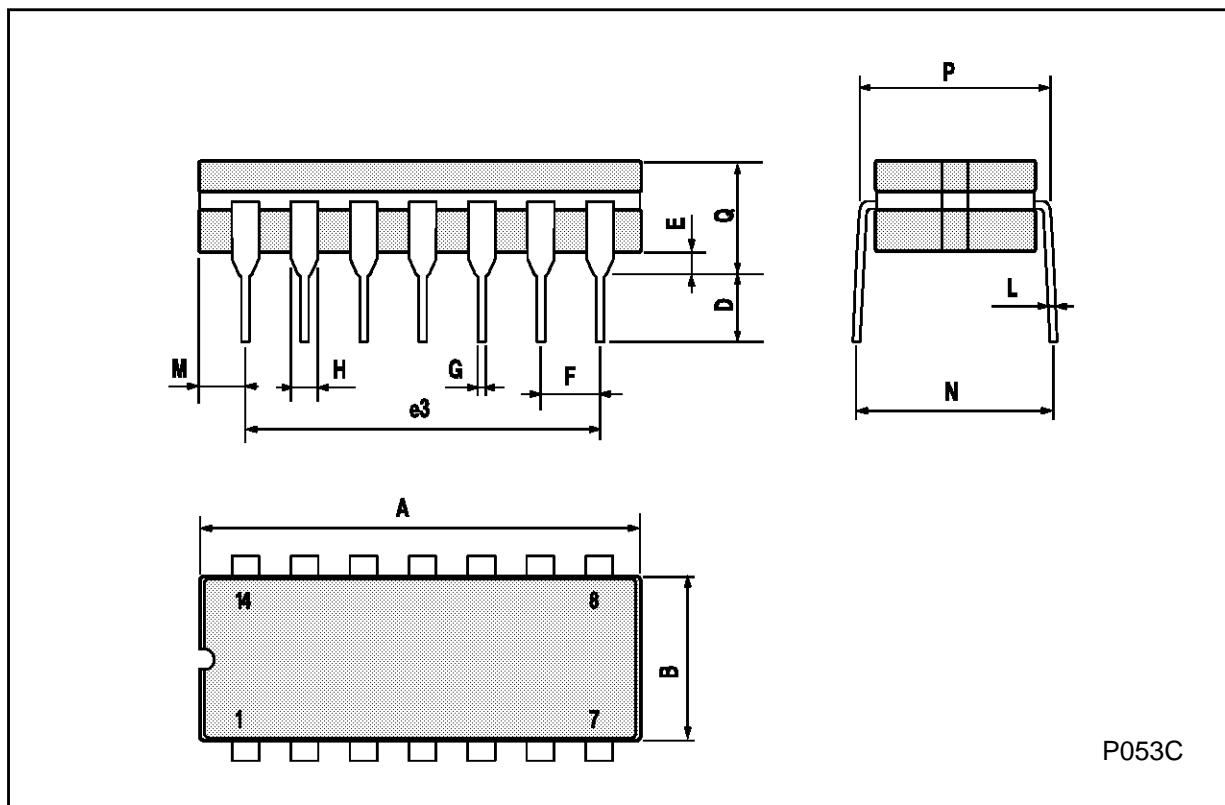
Plastic DIP14 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1	0.51			0.020		
B	1.39		1.65	0.055		0.065
b		0.5			0.020	
b1		0.25			0.010	
D			20			0.787
E		8.5			0.335	
e		2.54			0.100	
e3		15.24			0.600	
F			7.1			0.280
I			5.1			0.201
L		3.3			0.130	
Z	1.27		2.54	0.050		0.100



Ceramic DIP14/1 MECHANICAL DATA

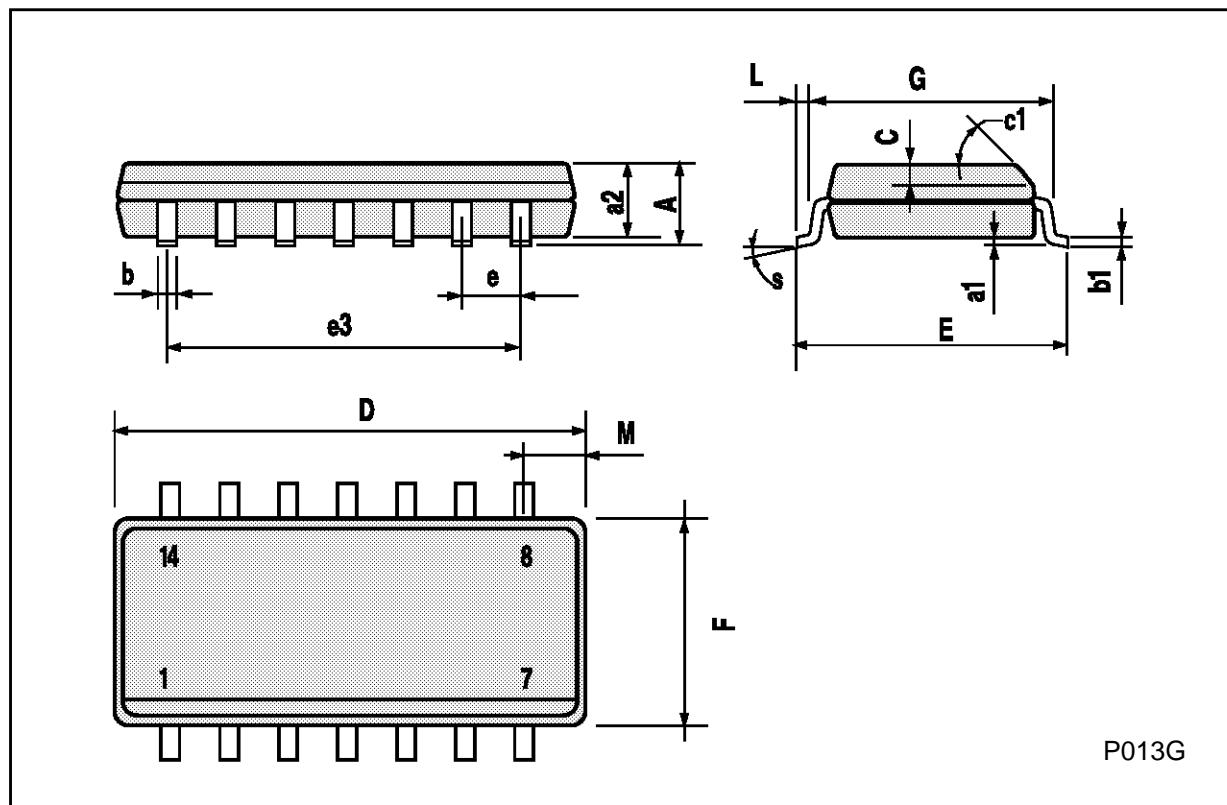
DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			20			0.787
B			7.0			0.276
D		3.3			0.130	
E	0.38			0.015		
e3		15.24			0.600	
F	2.29		2.79	0.090		0.110
G	0.4		0.55	0.016		0.022
H	1.17		1.52	0.046		0.060
L	0.22		0.31	0.009		0.012
M	1.52		2.54	0.060		0.100
N			10.3			0.406
P	7.8		8.05	0.307		0.317
Q			5.08			0.200



P053C

SO14 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.2	0.003		0.007
a2			1.65			0.064
b	0.35		0.46	0.013		0.018
b1	0.19		0.25	0.007		0.010
C		0.5			0.019	
c1		45° (typ.)				
D	8.55		8.75	0.336		0.344
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		7.62			0.300	
F	3.8		4.0	0.149		0.157
G	4.6		5.3	0.181		0.208
L	0.5		1.27	0.019		0.050
M			0.68			0.026
S		8° (max.)				



P013G

PLCC20 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	9.78		10.03	0.385		0.395
B	8.89		9.04	0.350		0.356
D	4.2		4.57	0.165		0.180
d1		2.54			0.100	
d2		0.56			0.022	
E	7.37		8.38	0.290		0.330
e		1.27			0.050	
e3		5.08			0.200	
F		0.38			0.015	
G			0.101			0.004
M		1.27			0.050	
M1		1.14			0.045	

